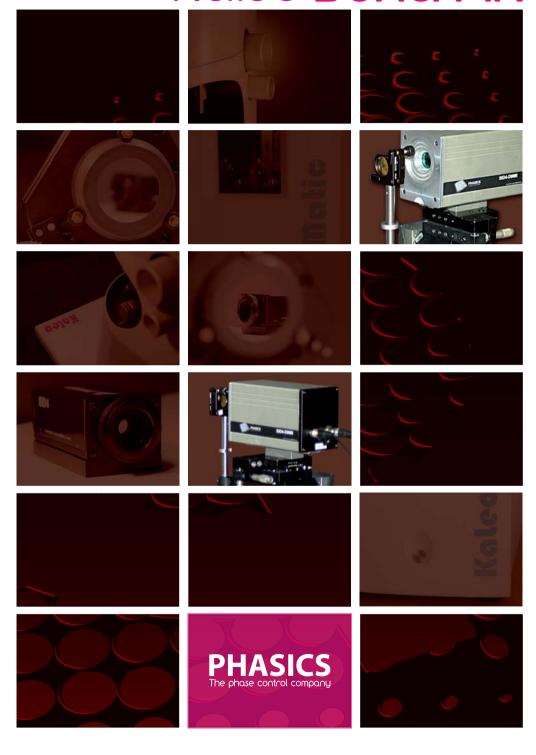
Kaleo Bench-IR



Kaleo **Bench-IR**



PHASICS creates the revolution in infrared optics quality control with the Kaleo Bench-IR series. These innovative benches offer both MTF and wavefront quality (aberrations, WFE) in one single fast acquisition. They cover the full IR range from 1.2 μm to 14 μm.

Their unique patented technology of unrivalled high resolution and sensitivity ensures an accurate characterization while simplifying set-up and alignment.

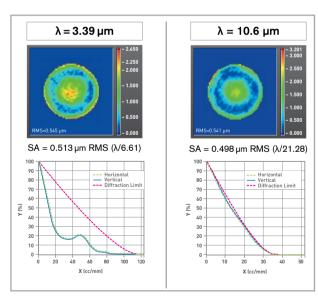
"MTF & WAVEFRONT ERROR WITH ONE BENCH"

☑ GET THE MTF...

- Along any direction
- For any pupil size
- On and off-axis
- Up to cut-off frequency
- With various focusing methods

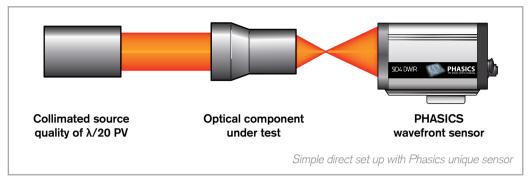
... AND MORE

- EFL, F#, NA
- Aberrations: Zernike, Seidel
- Real time filtering of phase map (Zernike, Kernel...)
- Chromatic aberrations
- TF MTF for any pupil size
- Comparison to design



Chromatic behaviour measured with one unique sensor on a ZnSe lens of 25.4 mm diameter. The focal spot shifts 560 µm due to refractive index dispersion.

BENCH FOR INFRARED OPTICS TESTING



Applies to lens, objective, zoom, strongly aberrated subassembly.

↓ UNIQUE TECHNOLOGY

- High resolution & high sensitivity for robust calculations and small defects detection
- **High dynamics** for testing & matching strongly aberrated optics subassemblies
- True achromaticity through the full IR range for chromatic response testing
- Direct measurement up to F/1

... for a simple set-up

- No relay lens
- Easy to align
- Cost effective

... for an easy interpretation

- Measurement in working conditions
- Rigorous calculation
- Results in any plane (best focus, paraxial)

→ FULLY INTEGRATED BENCH

- Powerful software with optional modules such as Design Pro for rigorous comparison to design files and RetroPro for characterization in the exit pupil
- Closed structure & motorization for safety compliance

	Flexible characterization at 3.39 & 10.6 µm	High resolution characterization at 10.6 µm	Chromatic high sensitivite characterization in MWIR region
	DWIR	LWIR	IR-MCT
Source	HeNe laser and/or CO ₂ laser	CO ₂ laser	Black body with spectral filters
Entrance pupil diameter	Up to 100 mm		
Maximum aperture	F/1		
Detector technology	Micro bolometer	Micro bolometer	Cooled MCT
Wavelength range	3 - 5 µm & 8 - 14 µm	8 - 14 µm	1.2 - 5.5 μm
Phase spatial resolution	140 µm	100 µm	60 µm
Phase sampling	96 x 72	160 x 120	160 x 128
Sensibility	25 nm RMS	25 nm RMS	3 nm RMS



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